

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination BETTNER ET AL.	
		Examiner Minh D. A	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0021250	02-2002	Asano et al.	343/702
	B	US-5,913,174	06-1999	Casarez et al.	455/557
	C	US-2004/0222928	11-2004	Chen, Farchien	343/702
	D	US-5,677,511	10-1997	Taylor et al.	174/52.2
	E	US-6,847,329	01-2005	Ikegaya et al.	343/702
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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